

MOSFET - N-Channel, Shielded Gate, POWERTRENCH®

100 V, 76 A, 8.5 m Ω

FDP8D5N10C, FDPF8D5N10C

General Description

This N-Channel MV MOSFET is produced using **onsemi**'s advanced POWERTRENCH process that incorporates Shielded Gate technology. This process has been optimized to minimize on-state resistance and yet maintain superior switching performance with best in class soft body diode.

Features

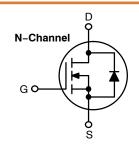
- Max $R_{DS(on)} = 8.5 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 76 \text{ A}$
- Extremely Low Reverse Recovery Charge, Qrr
- 100% UIL Tested
- RoHS Compliant

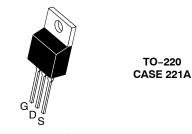
Applications

- Synchronous Rectification for ATX / Server / Telecom PSU
- Motor Drives and Uninterruptible Power Supplies
- Micro Solar Inverter

V _{DS}	R _{DS(ON)} MAX	I _D MAX
100 V	8.5 m Ω @ 10 V	76 A*

^{*}Drain current limited by maximum junction temperature.







MARKING DIAGRAM



XXX8D5N10C = Device Code (XXX = FDP, FDPF)

A = Assembly Location YWW = Date Code (Year & Week)

ZZ = Assembly Lot

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ORDERING INFORMATION

Device	Package	Shipping
FDP8D5N10C	TO-220	800 Units / Tube
FDPF8D5N10C	TO-220F	1000 Units / Tube

MOSFET MAXIMUM RATINGS ($T_C = 25^{\circ}C$ unless otherwise noted)

			Rat		
Symbol		Parameter	FDP8D5N10C	FDPF8D5N10C	Unit
V_{DS}	Drain to Source Voltage		100	100	V
V_{GS}	Gate to Source Voltage		±20	±20	V
I _D	Drain Current	– Continuous, T _C = 25°C (Note 3)	76	76*	Α
		- Continuous, T _C = 100°C (Note 3)	54	54*	
		- Pulsed (Note 1)	304	304*	
E _{AS}	Single Pulsed Avalanche I	Energy (Note 2)	181		mJ
P_{D}	Power Dissipation	T _C = 25°C	107	35	W
		T _A = 25°C	2.4	2.4	
T _J , T _{STG}	Operating and Storage Jul	nction Temperature Range	–55 to	+175	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.
*Drain current limited by maximum junction temperature.

- Pulsed Id please refer to Figure 11 and Figure 12 "Forward Bias Safe Operating Area" for more details.
 E_{AS} of 181 mJ is based on starting T_J = 25°C, L = 3 mH, I_{AS} = 11 A, V_{DD} = 100 V, V_{GS} = 10 V. 100% test at L = 0.3 mH, I_{AS} = 25 A.
 Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

THERMAL CHARACTERISTICS

Symbol	Parameter	FDP8D5N10C	FDPF8D5N10C	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case	1.4	4.2	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	62.5	62.5	

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
OFF CHAR	ACTERISTICS		-			
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	100	_	_	V
ΔBV_{DSS}	Breakdown Voltage Temperature	I _D = 250 μA, referenced to 25°C	-	57	-	mV/°C
ΔT_{J}	Coefficient					
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 80 V, V _{GS} = 0 V	-	-	1	μΑ
İ		V _{DS} = 80 V, T _J = 150°C	-	-	500	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	-	-	±100	nA
ON CHARA	CTERISTICS					
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 130 \mu A$	2.0	3.0	4.0	V
R _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 76 A	-	7.4	8.5	mΩ
9 _{FS}	Forward Transconductance	V _{DS} = 5 V, I _D = 76 A	-	68	-	S
DYNAMIC (CHARACTERISTICS					
C _{iss}	Input Capacitance	V _{DS} = 50 V, V _{GS} = 0 V, f = 1 MHz	_	1765	2475	pF
C _{oss}	Output Capacitance		-	1010	1415	pF
C _{rss}	Reverse Transfer Capacitance		-	16	25	pF
Rg	Gate Resistance		0.1	0.8	1.6	Ω
SWITCHING	G CHARACTERISTICS					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 50 \text{ V}, I_D = 76 \text{ A}, V_{GS} = 10 \text{ V},$	-	12	22	ns
t _r	Rise Time	$R_{GEN} = 6 \Omega$	-	11	20	ns
t _{d(off)}	Turn-Off Delay Time		_	18	28	ns
t _f	Fall Time		_	4	10	ns
Qg	Total Gate Charge	V_{GS} = 0 V to 10 V, V_{DD} = 50 V, I_D = 76 A	-	25	34	nC
Q_{gs}	Gate to Source Gate Charge	V _{DD} = 50 V, I _D = 76 A	-	9	-	nC
Q_{gd}	Gate to Drain "Miller" Charge		-	5	-	nC
Q _{oss}	Output Charge	V _{DD} = 50 V, V _{GS} = 0 V	-	68	-	nC
DRAIN-SO	URCE DIODE CHARACTERISTICS					
IS	Maximum Continuous Drain to Source Di	ode Forward Current	_	-	76	Α
I _{SM}	Maximum Pulsed Drain to Source Diode	Forward Current	-	-	304	Α
V _{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 76 A	-	1.0	1.3	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, V_{DD} = 50 \text{ V}, I_F = 76 \text{ A},$	-	58	92	ns
Q _{rr}	Reverse Recovery Charge	dl _F /dt = 100 A/μs	_	53	85	nC
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, V_{DD} = 50 \text{ V}, I_F = 76 \text{ A},$	-	51	81	ns
	Reverse Recovery Charge	dl _F /dt = 300 A/μs	—	+	-	+

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Normalized

A_{DS(on)}, Drain to Source On-Resistance (mΩ)

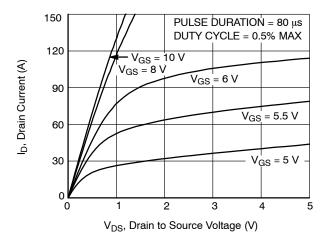


Figure 1. On-Region Characteristics

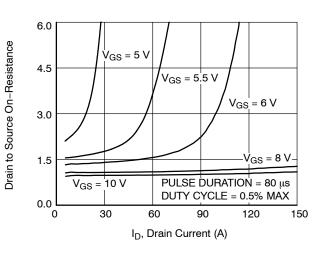


Figure 2. Normalized On–Resistance vs.

Drain Current and Gate Voltage

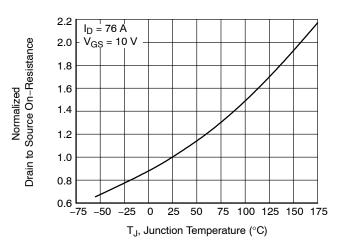


Figure 3. Normalized On–Resistance vs. Junction Temperature

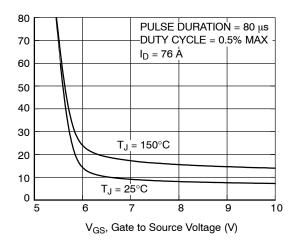


Figure 4. On-Resistance vs. Gate to Source Voltage

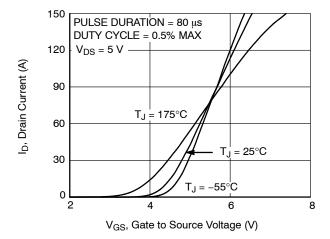


Figure 5. Transfer Characteristics

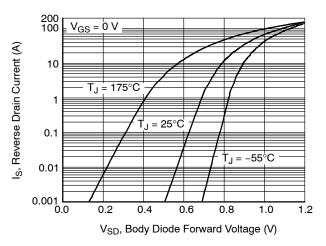


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS (T_{.1} = 25°C unless otherwise noted) (continued)

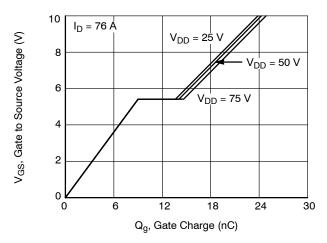


Figure 7. Gate Charge Characteristics

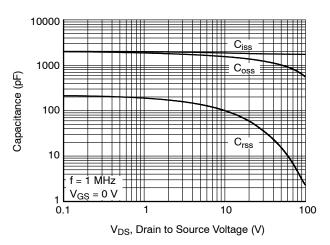


Figure 8. Capacitance vs. Drain to Source Voltage

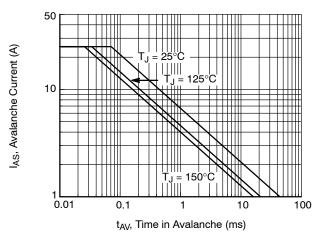


Figure 9. Unclamped Inductive Switching Capability

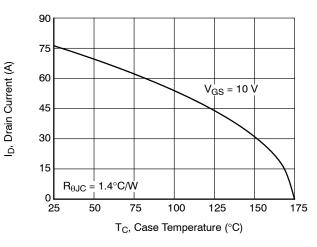


Figure 10. Maximum Continuous
Drain Current vs. Case Temperature
for FDP8D5N10C

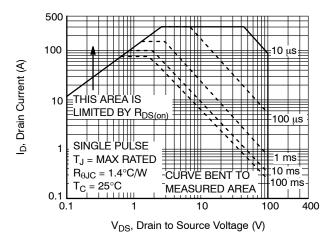


Figure 11. Forward Bias Safe Operating
Area for FDP8D5N10C

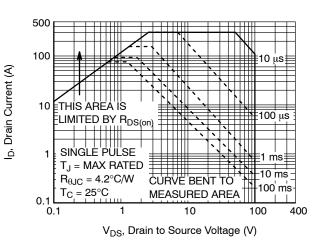
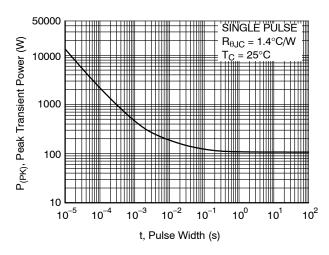


Figure 12. Forward Bias Safe Operating
Area for FDPF8D5N10C

TYPICAL PERFORMANCE CHARACTERISTICS (T, I = 25°C unless otherwise noted) (continued)



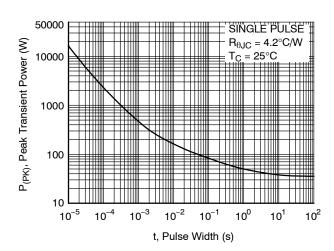


Figure 13. Single Pulse Maximum Power Dissipation for FDP8D5N10C

Figure 14. Single Pulse Maximum Power Dissipation for FDPF8D5N10C

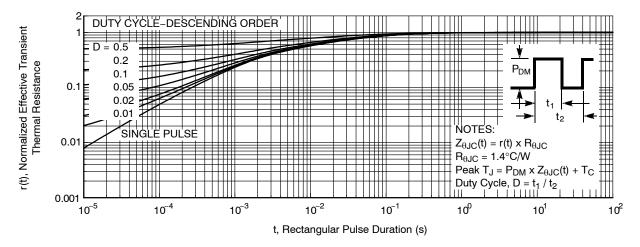


Figure 15. Junction-to-Case Transient Thermal Response Curve for FDP8D5N10C

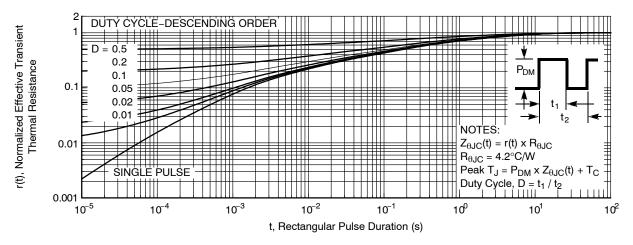
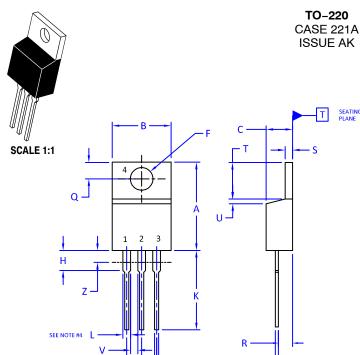


Figure 16. Junction-to-Case Transient Thermal Response Curve for FDPF8D5N10C







21A AK

DATE 13 JAN 2022

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: INCHES
- 3. DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

4. MAX WIDTH FOR F102 DEVICE = 1.35MM

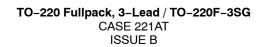
	INCHES		MILLIMI	ETERS
DIM	MIN.	MAX.	MIN.	MAX.
Α	0.570	0.620	14.48	15.75
В	0.380	0.415	9.66	10.53
С	0.160	0.190	4.07	4.83
D	0.025	0.038	0.64	0.96
F	0.142	0.161	3.60	4.09
G	0.095	0.105	2.42	2.66
Н	0.110	0.161	2.80	4.10
J	0.014	0.024	0.36	0.61
К	0.500	0.562	12.70	14.27
L	0.045	0.060	1.15	1.52
N	0.190	0.210	4.83	5.33
Q	0.100	0.120	2.54	3.04
R	0.080	0.110	2.04	2.79
S	0.045	0.055	1.15	1.41
Т	0.235	0.255	5.97	6.47
U	0.000	0.050	0.00	1.27
V	0.045		1.15	
Z		0.080		2.04

STYLE 1: PIN 1. 2. 3. 4.	BASE COLLECTOR EMITTER COLLECTOR	STYLE 2: PIN 1. 2. 3. 4.		STYLE 3: PIN 1. 2. 3. 4.	CATHODE ANODE GATE ANODE	STYLE 4: PIN 1. 2. 3. 4.	MAIN TERMINAL 1 MAIN TERMINAL 2 GATE MAIN TERMINAL 2
STYLE 5: PIN 1. 2. 3. 4.	GATE DRAIN SOURCE DRAIN	STYLE 6: PIN 1. 2. 3. 4.	ANODE CATHODE ANODE CATHODE	STYLE 7: PIN 1. 2. 3. 4.	ANODE	2. 3.	CATHODE ANODE EXTERNAL TRIP/DELAY ANODE
STYLE 9: PIN 1. 2. 3. 4.	GATE COLLECTOR EMITTER COLLECTOR	STYLE 10: PIN 1. 2. 3. 4.	GATE	STYLE 11: PIN 1. 2. 3. 4.		STYLE 12 PIN 1. 2. 3. 4.	MAIN TERMINAL 1 MAIN TERMINAL 2

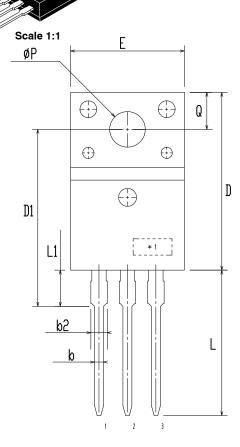
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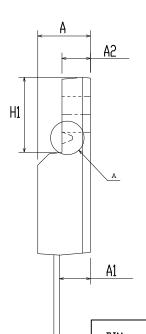
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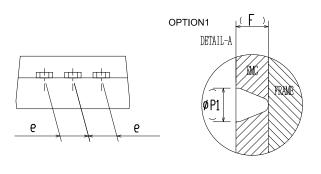




DATE 19 JAN 2021







DIM	LITE	LIIII I LIVO	
ויונע	MIN	NDM	MAX
Α	4.50	4.70	4.90
A1	2.56	2.76	2.96
A2	2.34	2.54	2.74
b	0.70	0.80	0.90
b2	~	2	1.47
С	0.45	0.50	0.60
D	15.67	15.87	16.07
D1	15.60	15.80	16.00
E	9.96	10.16	10.36
е	2.34	2.54	2.74
F	~	0.84	~
H1	6.48	6.68	6.88
L	12.78	12.98	13.18
L1	3.03	3.23	3.43
øΡ	2.98	3.18	3.38
ø P1	~	1.00	~
Q	3.20	3.30	3.40

MILL IMITERS

NOTES:

- A. DIMENSION AND TOLERANCE AS ASME Y14.5-2009
- B. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUCSIONS.

C

C. OPTION 1 - WITH SUPPORT PIN HOLE OPTION 2 - NO SUPPORT PIN HOLE

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